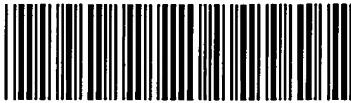


Search Notes

Application/Control No.

10/773,180

Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
359	326-332	3/2/2005	JDL
372	21,22	3/2/2005	JDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Files	Removed	3/4/2005	JDL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	3/2/2005	JDL